

**Notice of References Cited**

Application/Control No.

10/659,750

Applicant(s)/Patent Under  
Reexamination  
WOO ET AL.

Examiner

Marceau Milord

Art Unit

2618

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**U.S. PATENT DOCUMENTS**

| * |   | Document Number<br>Country Code-Number-Kind Code | Date<br>MM-YYYY | Name                | Classification |
|---|---|--|-----------------|---------------------|----------------|
| * | A | US-6,892,051                                     | 05-2005         | Schmitt et al.      | 455/41.2       |
| * | B | US-6,058,319                                     | 05-2000         | Sadler, John Thomas | 455/569.2      |
| * | C | US-6,195,572                                     | 02-2001         | Patterson et al.    | 455/570        |
| * | D | US-6,944,287                                     | 09-2005         | Mori, Ukyo          | 379/390.01     |
| * | E | US-7,096,047                                     | 08-2006         | Geren et al.        | 455/569.1      |
| * | F | US-7,117,021                                     | 10-2006         | Shearer et al.      | 455/569.2      |
| * | G | US-6,928,168                                     | 08-2005         | Kirkeby, Ole        | 381/1          |
| * | H | US-5,546,458                                     | 08-1996         | Iwami, Akiko        | 379/392.01     |
| * | I | US-6,052,603                                     | 04-2000         | Kinzalow et al.     | 455/557        |
| * | J | US-6,078,825                                     | 06-2000         | Hahn et al.         | 455/569.2      |
| * | K | US-6,075,999                                     | 06-2000         | Vilmi et al.        | 455/569.2      |
| * | L | US-6,163,690                                     | 12-2000         | Lilja, Patrik       | 455/574        |
|   | M | US-  |                 |                     |                |

**FOREIGN PATENT DOCUMENTS**

| * |   | Document Number<br>Country Code-Number-Kind Code | Date<br>MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
|   | N |  |                 |         |      |                |
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|   | T |  |                 |         |      |                |

**NON-PATENT DOCUMENTS**

| * |   | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
|   | U |   |
|   | V |   |
|   | W |   |
|   | X |   |

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**U.S. PATENT DOCUMENTS**

| * |   | Document Number<br>Country Code-Number-Kind Code | Date<br>MM-YYYY | Name                 | Classification |
|---|---|--|-----------------|----------------------|----------------|
| * | A | US-6,230,029                                     | 05-2001         | Hahn et al.          | 455/575.2      |
| * | B | US-6,339,696                                     | 01-2002         | Chan et al.          | 455/62         |
| * | C | US-6,397,086                                     | 05-2002         | Chen, Tonny          | 455/569.2      |
| * | D | US-6,636,749                                     | 10-2003         | Holmes et al.        | 455/569.2      |
| * | E | US-6,687,517                                     | 02-2004         | Kinnunen, Jan        | 455/569.1      |
| * | F | US-6,697,638                                     | 02-2004         | Larsson et al.       | 455/553.1      |
| * | G | US-6,007,328                                     | 12-1999         | Seyed Yagoobi et al. | 431/115        |
| * | H | US-6,304,764                                     | 10-2001         | Pan, Chun H.         | 455/569.2      |
| * | I | US-6,349,223                                     | 02-2002         | Chen, Tonny          | 455/569.2      |
| * | J | US-6,131,042                                     | 10-2000         | Lee et al.           | 455/556.1      |
| * | K | US-6,101,403                                     | 08-2000         | Masuda, Shiro        | 455/569.2      |
|   | L | US-  |                 |                      |                |
|   | M | US-  |                 |                      |                |

**FOREIGN PATENT DOCUMENTS**

| * |   | Document Number<br>Country Code-Number-Kind Code | Date<br>MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
|   | N |  |                 |         |      |                |
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|   | R |  |                 |         |      |                |
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|---|---|---|
|   | U |   |
|   | V |   |
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|   | X |   |

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